

## Product Summary

$BV_{DSS}$	$R_{DS(ON)} \text{ Max}$	$I_D$ $T_A = +25^\circ\text{C}$
-60V	105m $\Omega$ @ $V_{GS} = -10\text{V}$	-3.3A
	130m $\Omega$ @ $V_{GS} = -4.5\text{V}$	-3.0A

## Description and Applications

This MOSFET is designed to meet the stringent requirements of Automotive applications. It is qualified to AEC-Q101, supported by a PPAP and is ideal for use in:

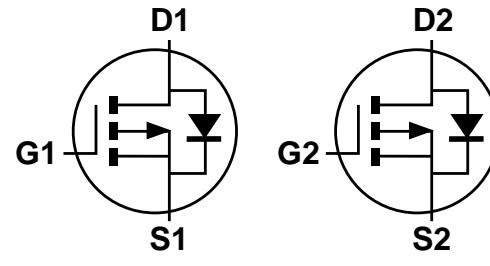
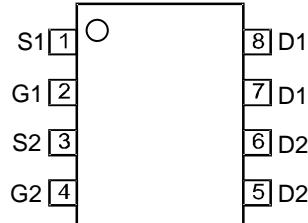
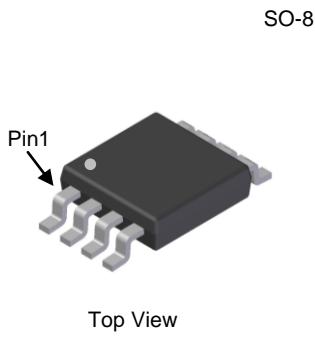
- Engine Management Systems
- Body Control Electronics
- DC-DC Converters

## Features

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **Qualified to AEC-Q101 Standards for High Reliability**
- **PPAP Capable (Note 4)**

## Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish – Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (E3)
- Weight: 0.074 grams (Approximate)



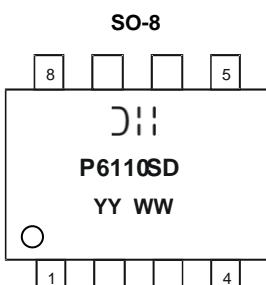
## Ordering Information (Note 5)

Part Number	Case	Packaging
DMP6110SSDQ-13	SO-8	2,500/Tape & Reel

Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
2. See [http://www.diodes.com/quality/lead\\_free.html](http://www.diodes.com/quality/lead_free.html) for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
4. Automotive products are AEC-Q101 qualified and are PPAP capable. Refer to [http://www.diodes.com/product\\_compliance\\_definitions.html](http://www.diodes.com/product_compliance_definitions.html).
5. For packaging details, go to our website at <http://www.diodes.com/products/packages.html>.

## Marking Information



DII = Manufacturer's Marking  
 P6110SD = Product Type Marking Code  
 YYWW = Date Code Marking  
 YY = Year (ex: 16 = 2016)  
 WW = Week (01 to 53)

**Maximum Ratings** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-60	V
Gate-Source Voltage	$V_{GSS}$	$\pm 20$	V
Continuous Drain Current (Note 7) $V_{GS} = -10\text{V}$	$T_C = +25^\circ\text{C}$	$I_D$	-7.8
	$T_C = +70^\circ\text{C}$		-6.3
Pulsed Drain Current (380 $\mu\text{s}$ Pulse, 1% Duty Cycle)	$T_A = +25^\circ\text{C}$	$I_D$	-3.3
	$T_A = +70^\circ\text{C}$		-2.7
Maximum Continuous Body Diode Forward Current (Note 7)	$I_{DM}$	-24	A
Avalanche Current (Note 10) $L = 0.1\text{mH}$	$I_S$	-1.8	A
Avalanche Energy (Note 10) $L = 0.1\text{mH}$	$I_{AS}$	-19	A
	$E_{AS}$	18	mJ

**Thermal Characteristics** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Notes 6 & 8)	$P_D$	1.2	W
		0.9	
		1.2	
Total Power Dissipation (Notes 6 & 9)	$R_{\theta JA}$	104	$^\circ\text{C}/\text{W}$
		45	
		100	
Thermal Resistance, Junction to Ambient (Notes 6 & 8)	$P_D$	1.7	W
		1.1	
		1.8	
Thermal Resistance, Junction to Ambient (Notes 7 & 9)	$R_{\theta JA}$	74	$^\circ\text{C}/\text{W}$
		37	
		71	
Thermal Resistance, Junction to Case (Notes 7 & 8)	$R_{\theta JC}$	15	
Operating and Storage Temperature Range	$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

Notes:

6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
7. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
8. For a dual device with one active die.
9. For a device with two active die running at equal power.
10.  $I_{AS}$  and  $E_{AS}$  ratings are based on low frequency and duty cycles to keep  $T_J = +25^\circ\text{C}$ .

**Electrical Characteristics** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS</b> (Note 11)						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	-60	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}$ , $\text{I}_D = -250\mu\text{A}$
Zero Gate Voltage Drain Current $T_J = +25^\circ\text{C}$	$\text{I}_{\text{DSS}}$	—	—	-1	$\mu\text{A}$	$\text{V}_{\text{DS}} = -48\text{V}$ , $\text{V}_{\text{GS}} = 0\text{V}$
Gate-Source Leakage	$\text{I}_{\text{GSS}}$	—	—	100	nA	$\text{V}_{\text{GS}} = \pm 16\text{V}$ , $\text{V}_{\text{DS}} = 0\text{V}$
<b>ON CHARACTERISTICS</b> (Note 11)						
Gate Threshold Voltage	$\text{V}_{\text{GS(TH)}}$	-1	—	-3	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}$ , $\text{I}_D = -250\mu\text{A}$
Static Drain-Source On-Resistance	$\text{R}_{\text{DS(ON)}}$	—	80	105	$\text{m}\Omega$	$\text{V}_{\text{GS}} = -10\text{V}$ , $\text{I}_D = -4.5\text{A}$
		—	95	130		$\text{V}_{\text{GS}} = -4.5\text{V}$ , $\text{I}_D = -3.5\text{A}$
Diode Forward Voltage	$\text{V}_{\text{SD}}$	—	-0.7	-1.2	V	$\text{V}_{\text{GS}} = 0\text{V}$ , $\text{I}_S = -1\text{A}$
<b>DYNAMIC CHARACTERISTICS</b> (Note 12)						
Input Capacitance	$\text{C}_{\text{ISS}}$	—	969	—	$\text{pF}$	$\text{V}_{\text{DS}} = -30\text{V}$ , $\text{V}_{\text{GS}} = 0\text{V}$ , $f = 1.0\text{MHz}$
Output Capacitance	$\text{C}_{\text{OSS}}$	—	57	—	$\text{pF}$	
Reverse Transfer Capacitance	$\text{C}_{\text{RSS}}$	—	44	—	$\text{pF}$	
Gate Resistance	$\text{R}_G$	—	13.7	—	$\Omega$	$\text{V}_{\text{DS}} = 0\text{V}$ , $\text{V}_{\text{GS}} = 0\text{V}$ , $f = 1.0\text{MHz}$
Total Gate Charge ( $\text{V}_{\text{GS}} = -4.5\text{V}$ )	$\text{Q}_G$	—	8.2	—	$\text{nC}$	$\text{V}_{\text{DS}} = -30\text{V}$ , $\text{I}_D = -12\text{A}$
Total Gate Charge ( $\text{V}_{\text{GS}} = -10\text{V}$ )	$\text{Q}_G$	—	17.2	—	$\text{nC}$	$\text{V}_{\text{DS}} = -30\text{V}$ , $\text{I}_D = -12\text{A}$
Gate-Source Charge	$\text{Q}_{\text{GS}}$	—	3.0	—	$\text{nC}$	
Gate-Drain Charge	$\text{Q}_{\text{GD}}$	—	3.1	—	$\text{nC}$	
Turn-On Delay Time	$\text{t}_{\text{D(ON)}}$	—	4.4	—	ns	$\text{V}_{\text{GS}} = -10\text{V}$ , $\text{V}_{\text{DS}} = -30\text{V}$ , $\text{R}_{\text{GEN}} = 3\Omega$ , $\text{I}_D = -12\text{A}$
Turn-On Rise Time	$\text{t}_R$	—	23	—	ns	
Turn-Off Delay Time	$\text{t}_{\text{D(OFF)}}$	—	34	—	ns	
Turn-Off Fall Time	$\text{t}_F$	—	42	—	ns	
Body Diode Reverse Recovery Time	$\text{t}_{\text{RR}}$	—	13.2	—	ns	$\text{I}_S = -12\text{A}$ , $\text{di/dt} = 100\text{A}/\mu\text{s}$
Body Diode Reverse Recovery Charge	$\text{Q}_{\text{RR}}$	—	6.18	—	$\text{nC}$	

Notes: 11. Short duration pulse test used to minimize self-heating effect.

12. Guaranteed by design. Not subject to product testing.

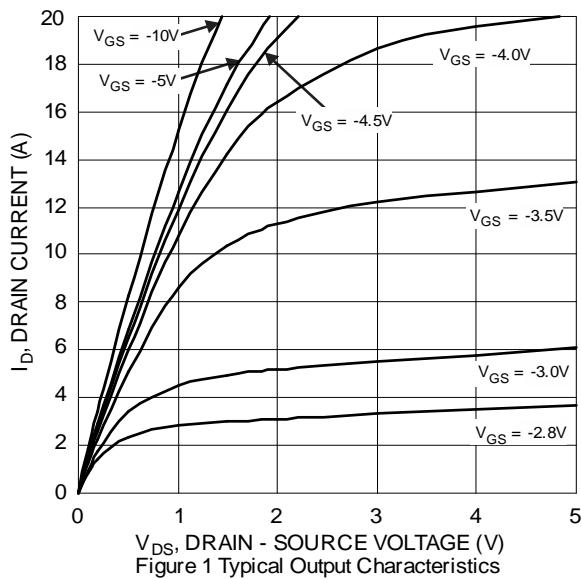


Figure 1 Typical Output Characteristics

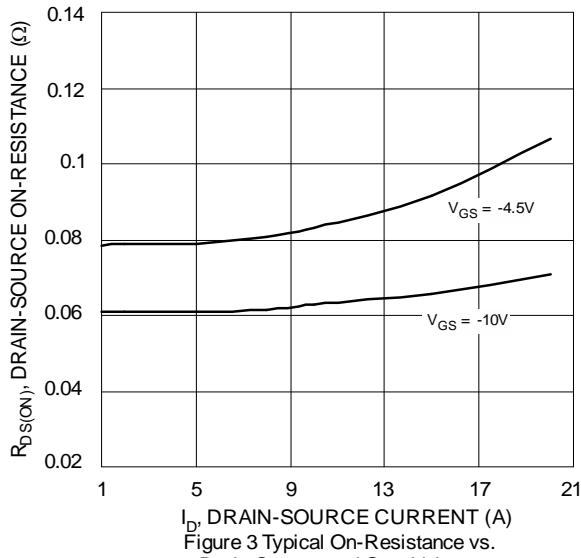


Figure 3 Typical On-Resistance vs.  
Drain Current and Gate Voltage

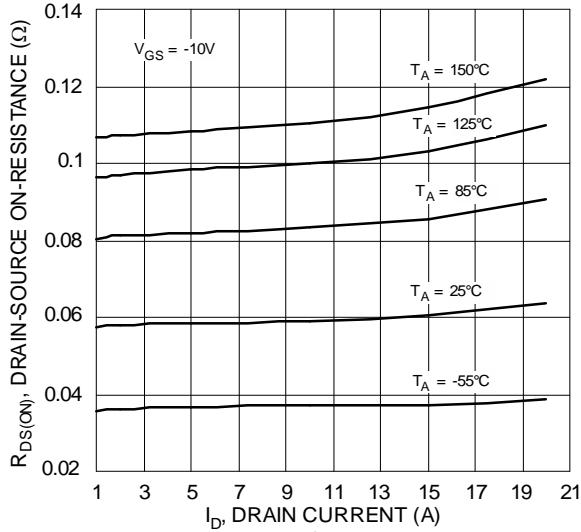


Figure 5 Typical On-Resistance vs.  
Drain Current and Temperature

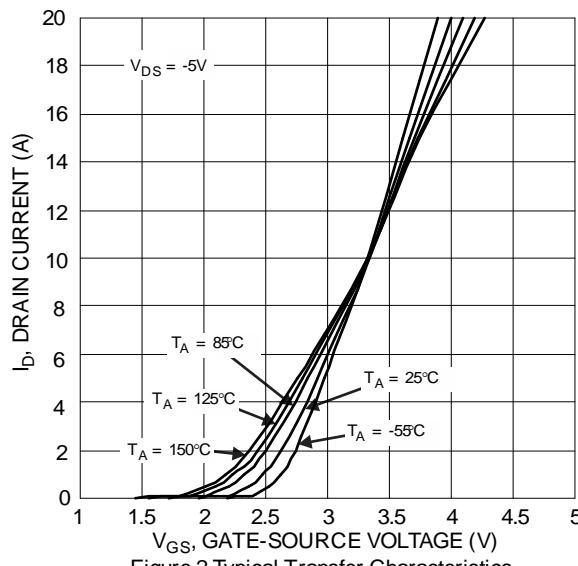


Figure 2 Typical Transfer Characteristics

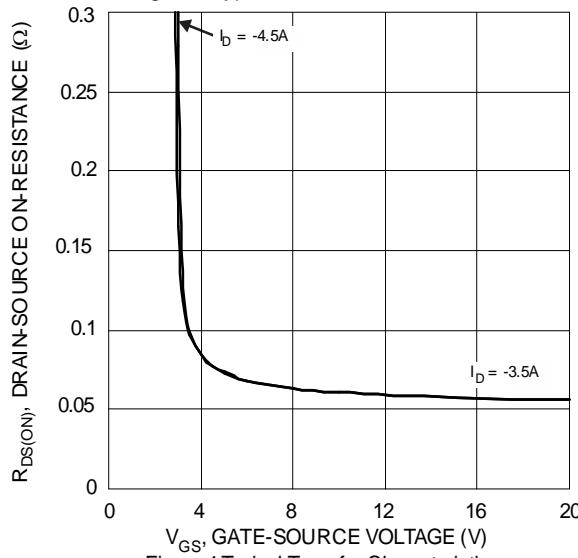


Figure 4 Typical Transfer Characteristics

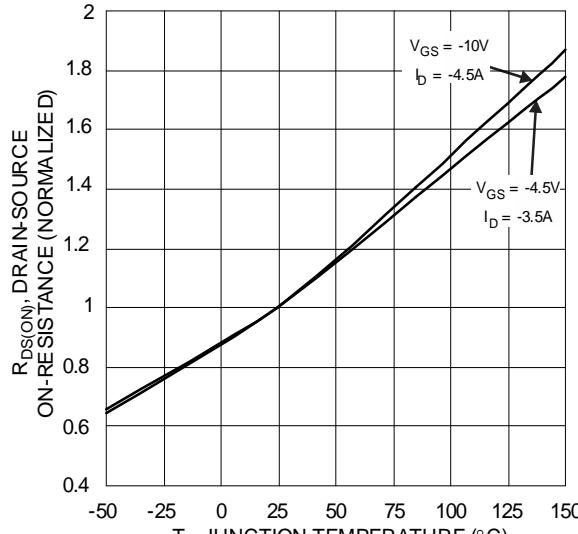


Figure 6 On-Resistance Variation with Temperature

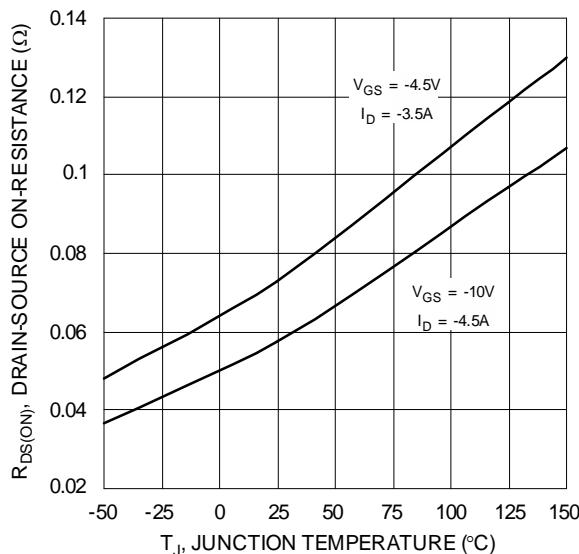


Figure 7 On-Resistance Variation with Temperature

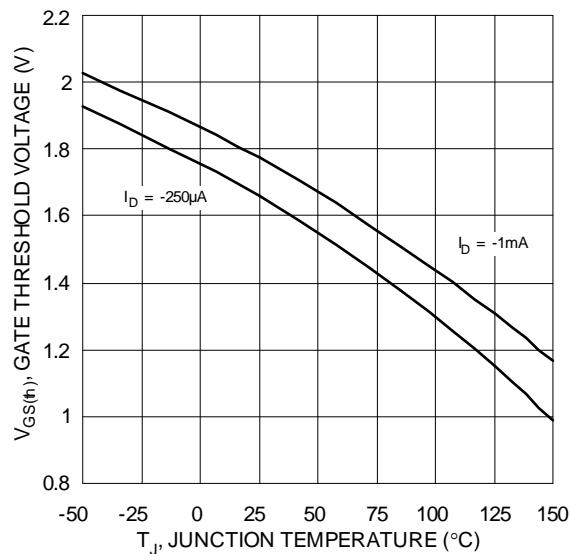


Figure 8 Gate Threshold Variation vs. Junction Temperature

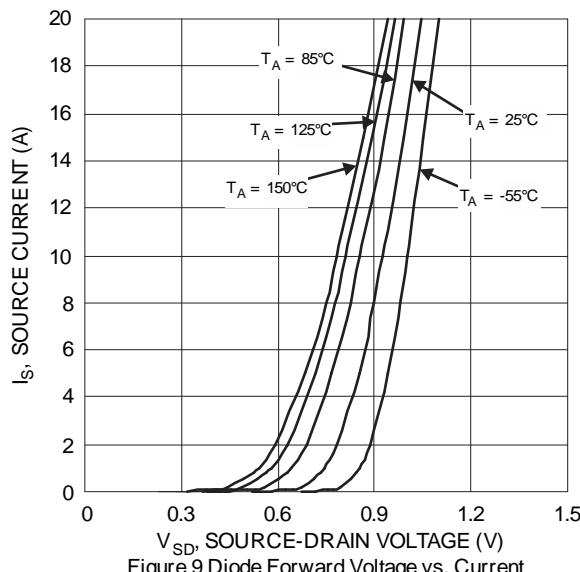


Figure 9 Diode Forward Voltage vs. Current

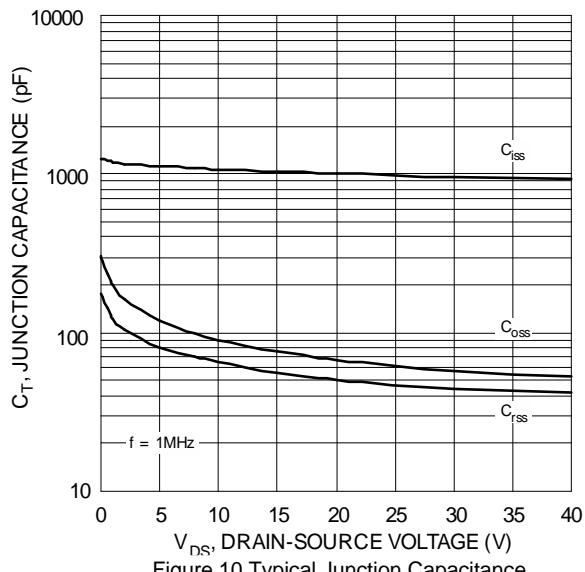


Figure 10 Typical Junction Capacitance

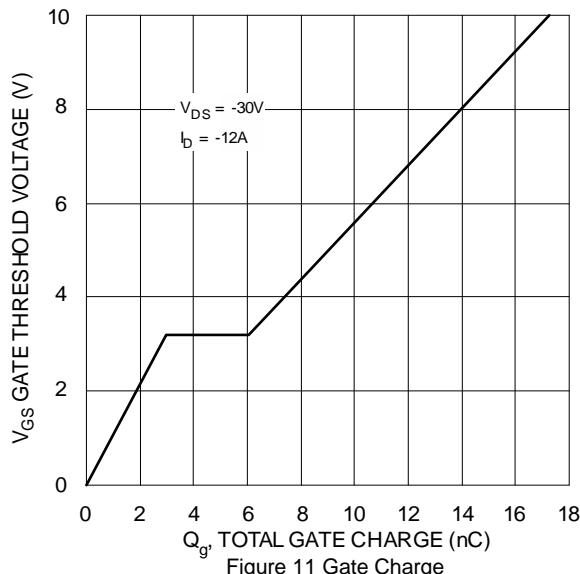


Figure 11 Gate Charge

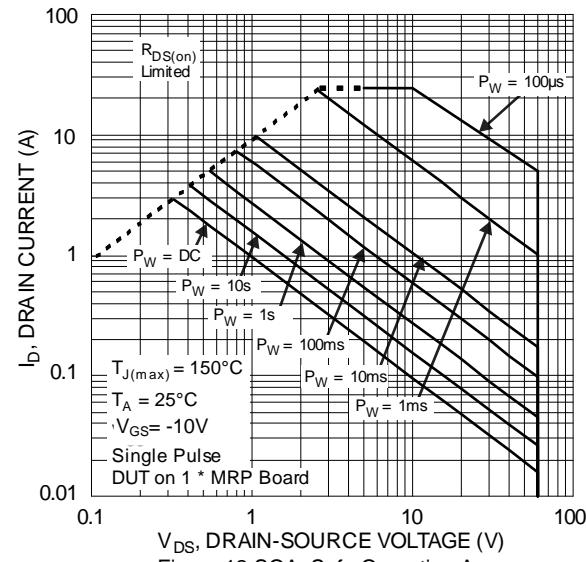


Figure 12 SOA, Safe Operation Area

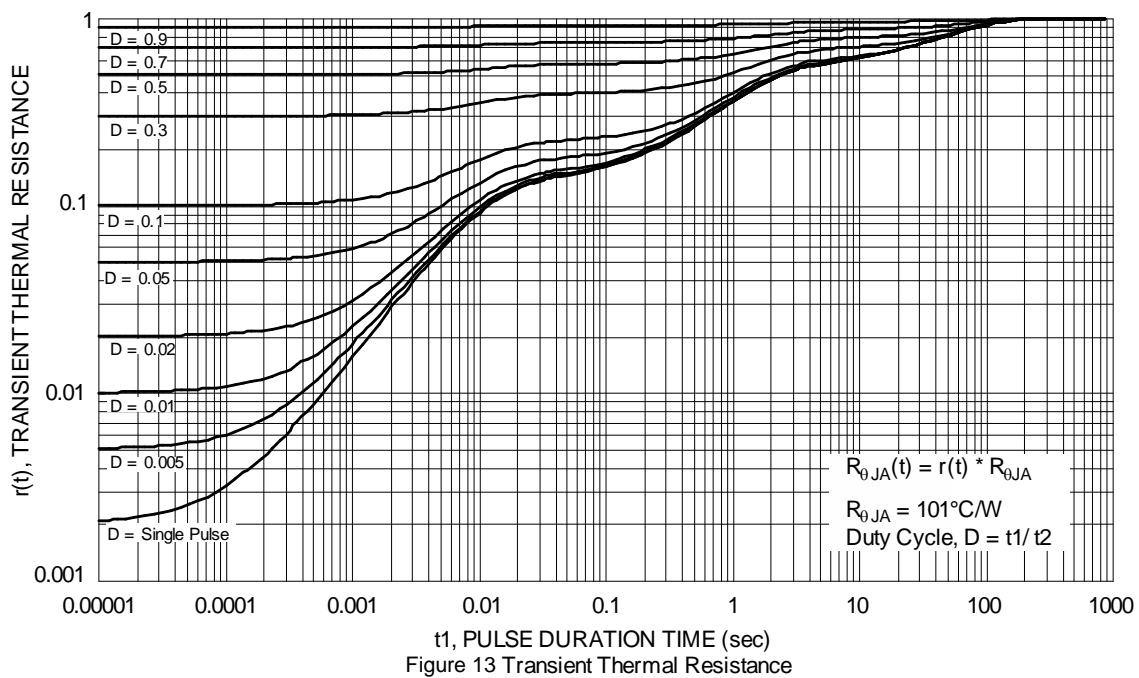
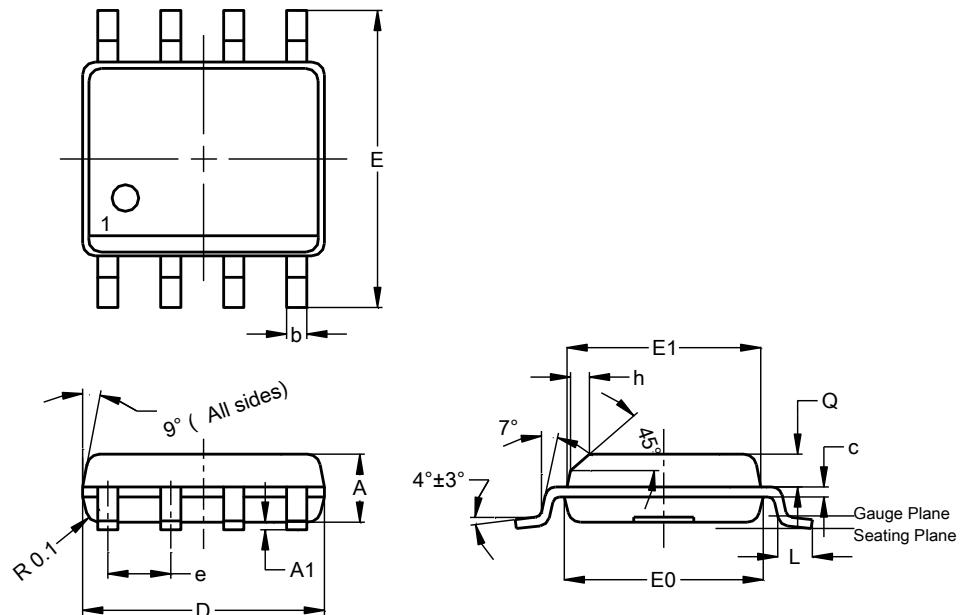


Figure 13 Transient Thermal Resistance

## Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

SO-8



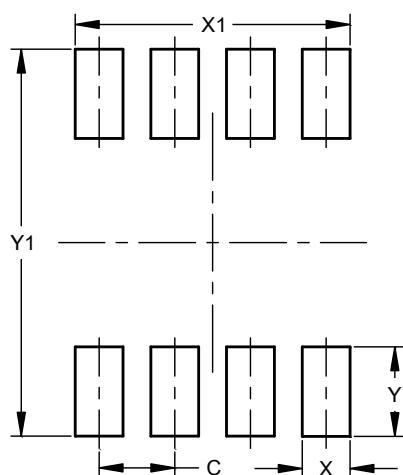
SO-8			
Dim	Min	Max	Typ
<b>A</b>	1.40	1.50	1.45
<b>A1</b>	0.10	0.20	0.15
<b>b</b>	0.30	0.50	0.40
<b>c</b>	0.15	0.25	0.20
<b>D</b>	4.85	4.95	4.90
<b>E</b>	5.90	6.10	6.00
<b>E1</b>	3.80	3.90	3.85
<b>E0</b>	3.85	3.95	3.90
<b>e</b>	--	--	1.27
<b>h</b>	-	--	0.35
<b>L</b>	0.62	0.82	0.72
<b>Q</b>	0.60	0.70	0.65

All Dimensions in mm

## Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

SO-8



Dimensions	Value (in mm)
<b>C</b>	1.27
<b>X</b>	0.802
<b>X1</b>	4.612
<b>Y</b>	1.505
<b>Y1</b>	6.50

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